



P-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$	I _D (A) ^d	Q _g (Typ.)		
- 30	0.005 at V _{GS} = - 10 V	- 29	61 nC		
- 30	0.00775 at $V_{GS} = -4.5 \text{ V}$	- 23			

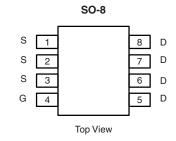
FEATURES

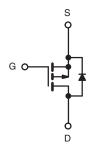
- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET® Power MOSFET
- 100 % R_a and UIS Tested
- Compliant to RoHS Directive 2002/95/EC



APPLICATIONS

- Adaptor Switch
- Notebook





Ordering Information: Si4459ADY-T1-GE3 (Lead (Pb)-free and Halogen-free)

P-Channel MOSFET

Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V _{DS}	- 30	V		
Gate-Source Voltage	V _{GS}	± 20	V		
	T _C = 25 °C		- 29		
Continuous Drain Current /T 150 °C)	T _C = 70 °C		- 23.5		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	- 19.7 ^{a, b}		
	T _A = 70 °C		- 15.6 ^{a, b}		
Pulsed Drain Current	I _{DM}	- 70	Α		
Continuous Course Dunin Diada Current	T _C = 25 °C		- 6.5		
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	- 2.9 ^{a, b}		
Avalanche Current	1 04 mill	I _{AS}	- 30		
Single-Pulse Avalanche Energy	L = 0.1 mH	E _{AS}	45	mJ	
	T _C = 25 °C		7.8		
Manianum Davina Disabatian	T _C = 70 °C	ь —	5	w	
Maximum Power Dissipation	T _A = 25 °C	P _D	3.5 ^{a, b}	VV	
	T _A = 70 °C		2.2 ^{a, b}		
Operating Junction and Storage Temperature Rang	T _J , T _{stg}	- 55 to 150	°C		

THERMAL RESISTANCE RATINGS						
Parameter	Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient ^{a, c}	t ≤ 10 s	R _{thJA}	29	35	°C/W	
Maximum Junction-to-Foot	Steady State	R_{thJF}	13	16	C/VV	

Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- b. t = 10 s.
- c. Maximum under steady state conditions is 80 °C/W.
- d. Based on $T_C = 25$ °C.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$			- 31		14/0	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = - 250 μA		5.3		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 1		- 2.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100		
-		$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}$			- 100	nA	
Zana Oaka Vallana Busin Oamani		$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}$			- 75		
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 75 \text{ °C}$			- 10	μА	
		$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 75 ^{\circ}\text{C}$			- 3		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge -10 \text{ V}, V_{GS} = -10 \text{ V}$	- 30			Α	
	D	V _{GS} = - 10 V, I _D = - 15 A		0.0039	0.005	Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 4.5 V, I _D = - 10 A		0.0062	0.00775		
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 10 V, I _D = - 15 A		24		S	
Dynamic ^b					L	L	
Input Capacitance	C _{iss}			6000			
Output Capacitance	C _{oss}	$V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		860		pF	
Reverse Transfer Capacitance	C _{rss}			790		1	
Total Cata Chausa		$V_{DS} = -15 \text{ V}, V_{GS} = -10 \text{ V}, I_{D} = -20 \text{ A}$		129	195	nC	
Total Gate Charge	Q _g V _{DS} = 13 v, v _{GS} = 10 v,			61	95		
Gate-Source Charge	Q _{gs}	$V_{DS} = -15 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -20 \text{ A}$		16.5			
Gate-Drain Charge	Q _{gd}			23.5			
Gate Resistance	R_{g}	f = 1 MHz	0.6	3	6	Ω	
Turn-On Delay Time	t _{d(on)}			16	30		
Rise Time	t _r	V_{DD} = - 15 V, R_L = 1.5 Ω		16	30		
Turn-Off DelayTime	t _{d(off)}	$I_D \cong -10 \text{ A}, V_{GEN} = -10 \text{ V}, R_g = 1 \Omega$		80	150		
Fall Time	t _f			20	40		
Turn-On Delay Time	t _{d(on)}			75	150	ns	
Rise Time	t _r	V_{DD} = - 15 V, R_L = 1.5 Ω		130	260		
Turn-Off DelayTime	t _{d(off)}	$I_D \cong$ - 10 A, V_{GEN} = - 4.5 V, R_g = 1 Ω		60	120		
Fall Time	t _f	-		40	80		
Drain-Source Body Diode Characteris	stics				•		
Continous Source-Drain Diode Current	I _S	T _C = 25 °C			- 29	Α	
Pulse Diode Forward Current	I _{SM}				- 70	A	
Body Diode Voltage	V _{SD}	$I_S = -3 \text{ A}, V_{GS} = 0 \text{ V}$		- 0.71	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			67	130	ns	
Body Diode Reverse Recovery Charge		$I_F = -5 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 \text{ °C}$		74	150	nC	
Reverse Recovery Fall Time				22		ns	
Reverse Recovery Rise Time	t _b			45			

Notes:

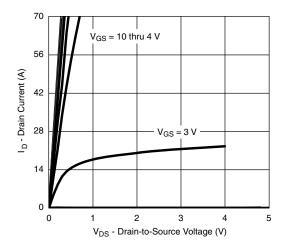
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

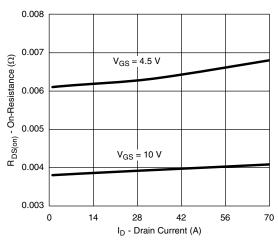
b. Guaranteed by design, not subject to production testing.



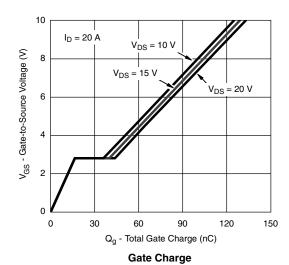
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

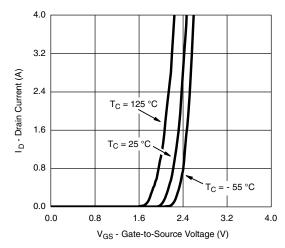


Output Characteristics

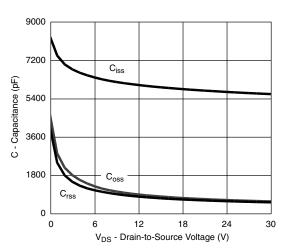


On-Resistance vs. Drain Current

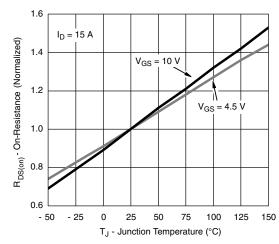




Transfer Characteristics

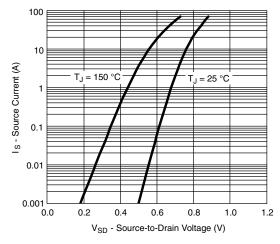


Capacitance

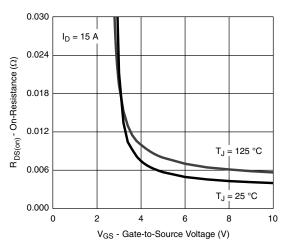


On-Resistance vs. Junction Temperature

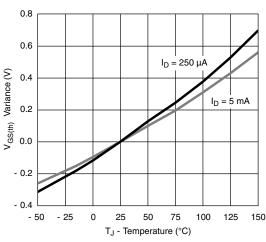
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



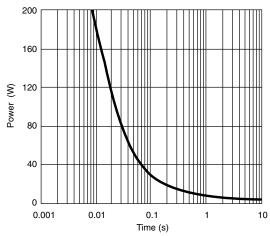
Source-Drain Diode Forward Voltage



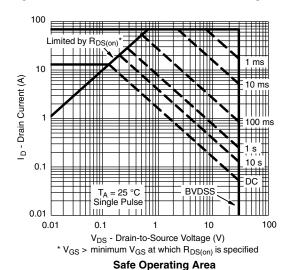
On-Resistance vs. Gate-to-Source Voltage



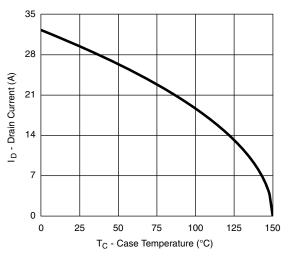
Threshold Voltage



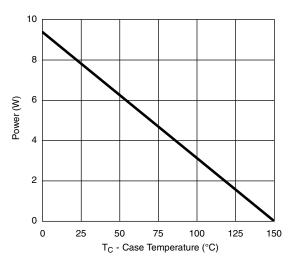
Single Pulse Power, Junction-to-Ambient



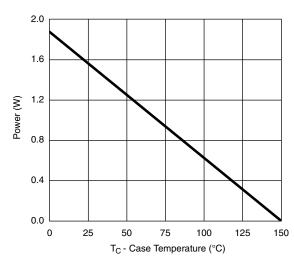
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Current Derating*



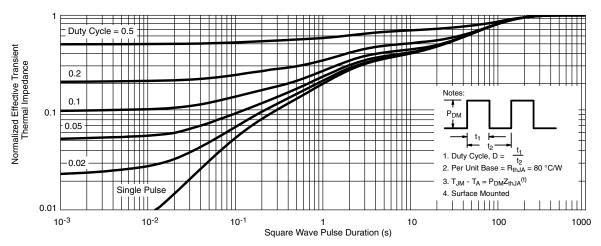




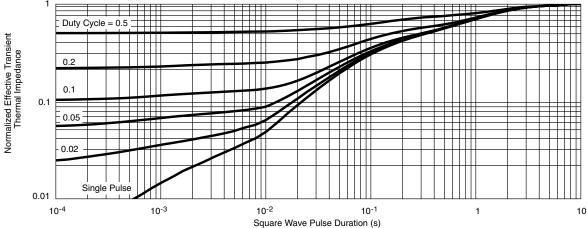
Power Derating, Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

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SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







	MILLIMETERS INCHES			HES		
DIM	Min	Max	Min	Max		
Α	1.35	1.75	0.053	0.069		
A ₁	0.10	0.20	0.004	0.008		
В	0.35	0.51	0.014	0.020		
С	0.19	0.25	0.0075	0.010		
D	4.80	5.00	0.189	0.196		
Е	3.80	4.00	0.150	0.157		
е	1.27	BSC	0.050 BSC			
Н	5.80	6.20	0.228	0.244		
h	0.25	0.50	0.010	0.020		
L	0.50	0.93	0.020	0.037		
q	0°	8°	0°	8°		
S	0.44	0.64	0.018	0.026		
ECN: C-06527-Rev. I. 11-Sep-06						

DWG: 5498

Document Number: 71192 www.vishay.com 11-Sep-06



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)

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